Page 1of 2

		1 490 1012	
FORM PTO-1449 U.S DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 2002DE142	SERIAL NO. 10/533,999	
(37 CFR 1.98(b))			
MAR 2 3 2006	APPLICANT: Michel et al.		
2000	FILING DATE: 5/4/2006	GROUP: 1751	
& TRADEMARK			

U.S. PATENT DOCUMENTS

Examiner Initial		Patent Number	Issue Dte	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	3,671,553	6/20/1972	Papenfuss et al.			
	АВ	5,061,585	10/29/1991	Macholdt et al.			
	AC	2002098435	7/25/2002	Rohr et al.			
	AD	6,028,178	2/22/2000	Metz et al.			-
	AE	5,554,722	9/10/1996	Eichenauer et al.			
	AF	5,871,845	2/16/1999	Dahringer et al.			
	AG	6,117,606	9/12/2000	Macholdt et al.			
	АН	6,391,507	5/21/2002	Macholdt et al.		1	
	AI	6,406,528	6/18/2002	Macholdt et al.			
	AJ	5,069,994	12/3/1991	Gitzel et al.			
	AK	5,021,473	6/4/1991	Macholdt et al.			
	AL	5,147,748	9/15/1992	Gitzel et al.			
	AM	5,560,760	10/1/1996	Toeppen			
	AN	5,922,118	7/13/1999	Johnson et al.	*****		
	AO	5,554,739	9/10/1996	Belmont			
	AP	5,342,723	8/30/1994	Macholdt et al.			
	AQ	5,475,119	12/12/1995	Baur et al.			
	AR	5,563,016	10/8/1996	Baur et al.			
	AS	5,401,809	3/28/1995	Gitzel et al.			
	AT	5,110,518	5/5/1992	Hatter			
	AU	5,378,571	1/3/1995	Macholdt et al.			
	AV	4,912,006	3/27/1990	Breitschaft et al.			
	AW	5,585,216	12/17/1996	Baur et al.			
	AX	5,502,118	3/26/1996	Machholot et al.			
	AY	6,083,653	7/4/2000	Baur et al.		·	
	AZ	6,030,738	2/29/2000	Michel et al.			
	A1		-				
	A2						
EXAMINER	*		-	DATE CONSIDERED	<u></u>	. ,	

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Page 2of 2

MAR 2 3 7006

FEWeb Receipt date: 03/23/2006

FOREIGN PATENT OR PUBLISHED FOREIGN APPLICATION					
	DOCUMENT NUMBER	PUB. DATE	COUNTRY		TRANSLATION
ВА	WO 8804442	6/16/1988	WIPO		See AB above
ВВ	EP 1204005	5/8/2002	EPO	·	See AC above
ВС	WO 8909833	10/19/1989	WIPO		English
BD	EP 0705886	4/10/1996	EPO		See AD above
BE	EP 0658819	6/21/1995	EPO		English
BF	EP 0639611	2/22/1995	EPO		See AE above
BG	EP 0615007	9/14/1994	EPO		See AF above
вн	EP 0623941	11/9/1994	EPO		English
ВІ	EP 0908789	4/14/1999	EPO		See AG above
 ВЈ	EP 1061419	12/22/2000	EPO		See AH through AI above
вк	WO 91/10172	7/11/1991	WIPO		See AP above
BL	DE 4142541	6/24/1993	Germany		See AQ & AR above
ВМ	DE 4029652	3/26/1992	Germany		See AS above
BN	DE 4013610	5/2/1991	Germany		See AT above
во	DE 4031705	4/9/1992	Germany		See AU above
ВР	EP 0258651	3/9/1988	EPO		English
BQ	EP 0385580	9/5/1990	EPO		English
BR	EP 0347695	2/27/1989	EPO		See AV above
BS	DE 4418842	12/7/1995	Germany		See AW above
вт	DE 4332170	3/23/1995	Germany		See AX above
BU	DE 19711260	9/24/1998	Germany		See AY above
BV	DE 19732995	2/4/1999	Germany		See AZ above
BW	WO 01/40878	6/7/2001	WIPO		English Abstract
BX	EP 0636945	2/1/1995	EPO		English
ВҮ	EP 0778501	6/11/1997	EPO		English
BZ	WO 01/30919	5/3/2001	WIPO		English

OTHER DOCUMENTS (Including Author, Title, Date, Place of Publication**)

	CA		PCT ISR for PCT/EP 03/11620, 2/23/2004	
	СВ		English Abstract for JP 9106107, 4/22/1997.	
	СС			
	CD			
	CE			
	CF			
	CG			
EXAMINER DATE CONSIDERED				
EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.				